



SK03N50-TF

500V N-ch Planar MOSFET

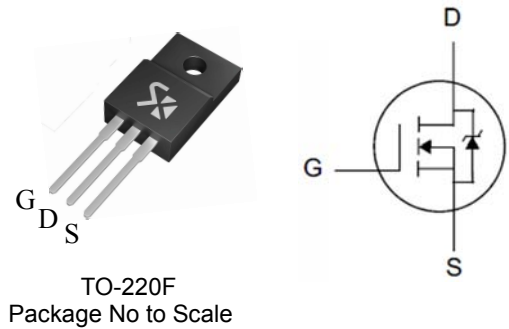
General Features

- RoHS Compliant
- $R_{DS(ON),typ.}=3.1\ \Omega @ V_{GS}=10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- Adaptor
- Charger
- SMPS Standby Power

BV_{DSS}	$R_{DS(ON),typ.}$	I_D
500V	3.1 Ω	3.0A



TO-220F
Package No to Scale

Electrical Characteristics¹ ($T_j=25^\circ\text{C}$)

Parameter	Description	Min.	Typ.	Max.	Unit	Test Condition
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	500	—	—	V	$V_{GS}=0V$, $I_D=250\mu A$
$R_{DS(ON)}$	Static Drain-Source On-Resistance	—	3.1	3.8	Ω	$V_{GS}=10V$, $I_D=1.5A$
$V_{GS(th)}$	Gate Threshold Voltage	2	—	4	V	$V_{DS}=V_{GS}$, $I_D=250\mu A$
I_{DSS}	Drain-to-Source Leakage Current	—	—	1	μA	$V_{DS}=500V$, $V_{GS}=0V$
I_{GSS}	Gate-Body Leakage Current	—	—	± 100	nA	$V_{DS}=0V$, $V_{GS}=\pm 30V$

Thermal Characteristics

Symbol	Parameter	SK04N65B-TF	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	4.17	$^\circ\text{C}/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	

Typical Characteristics

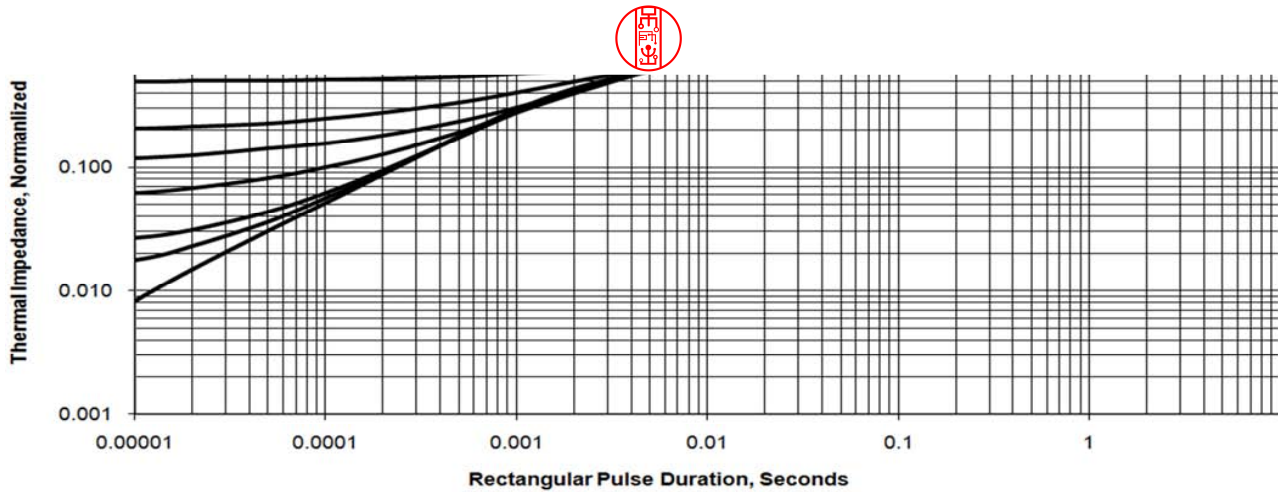


Figure 2 . Maximum Power Dissipation vs Case Temperature

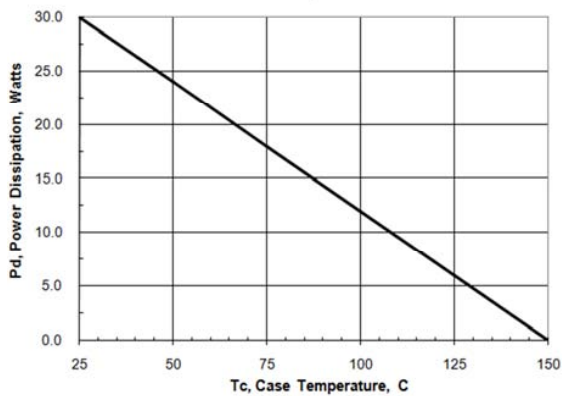


Figure 3 .Maximum Continuous Drain Current vs Case Temperature

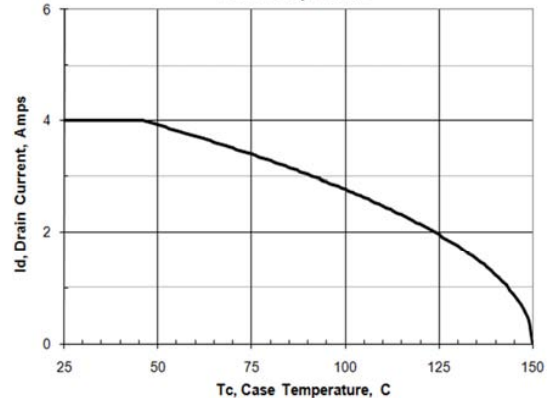


Figure 4. Typical Output Characteristics

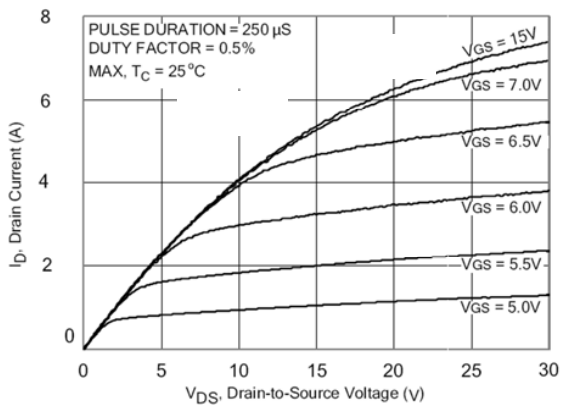
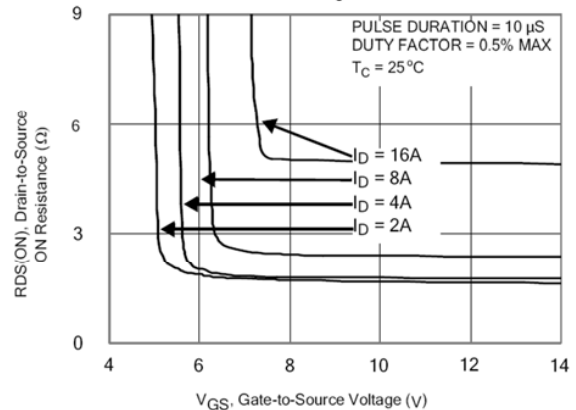


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



Typical Characteristics(Cont.)

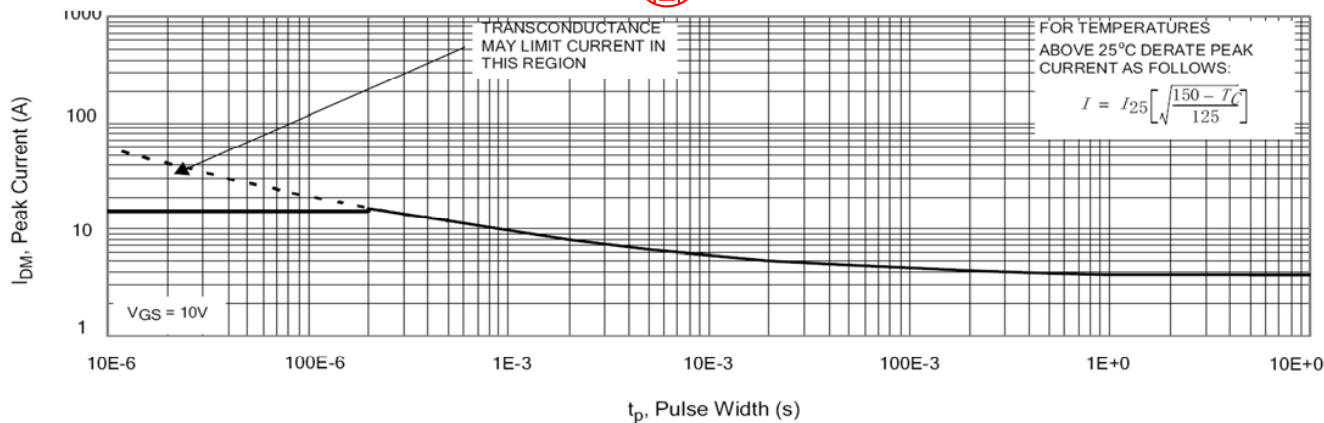


Figure 7. Typical Transfer Characteristics

Figure 8. Unclamped Inductive Switching Capability

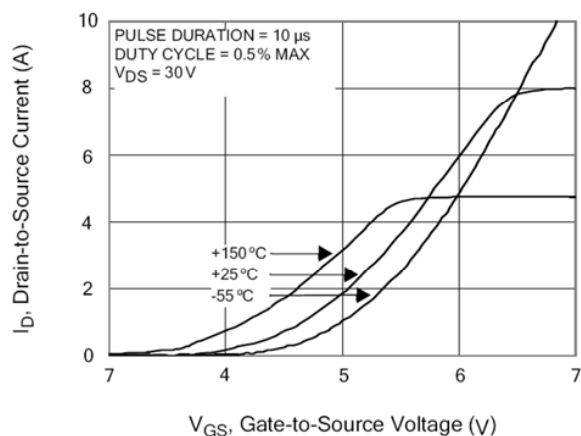


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

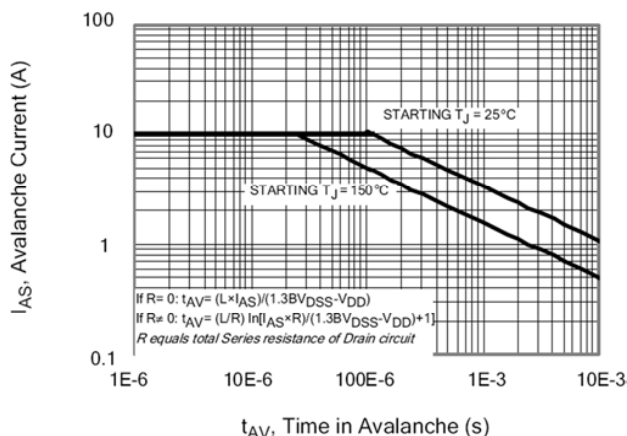
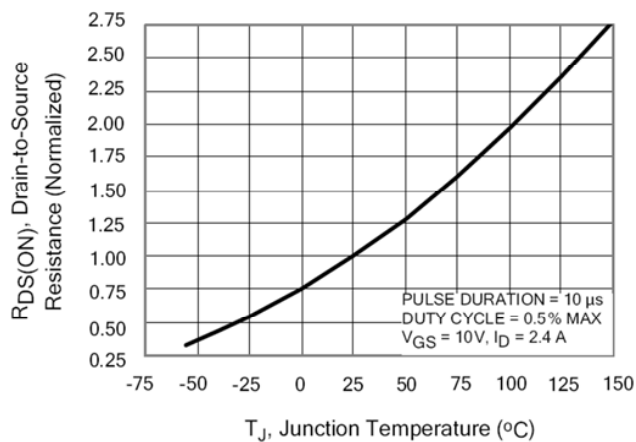
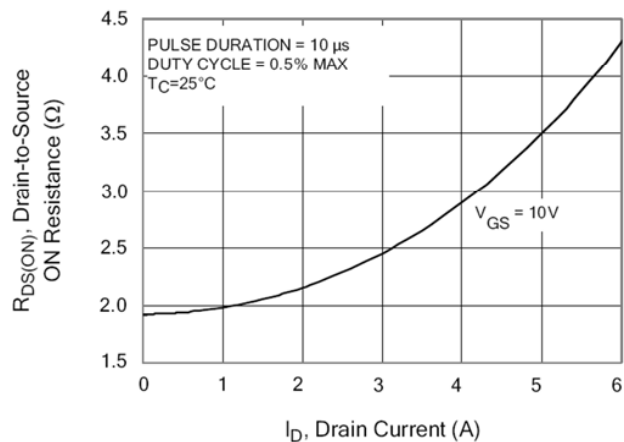


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature



Typical Characteristics(Cont.)

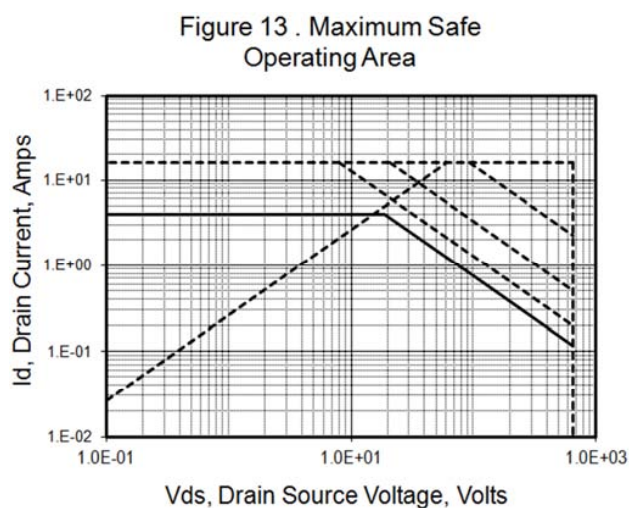
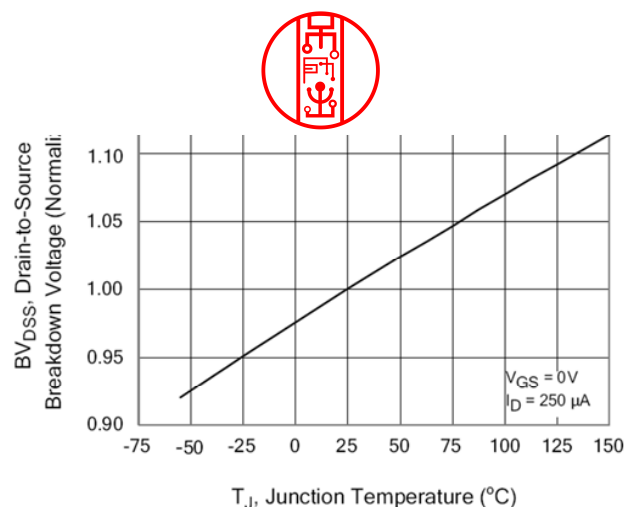


Figure 15. Typical Gate Charge

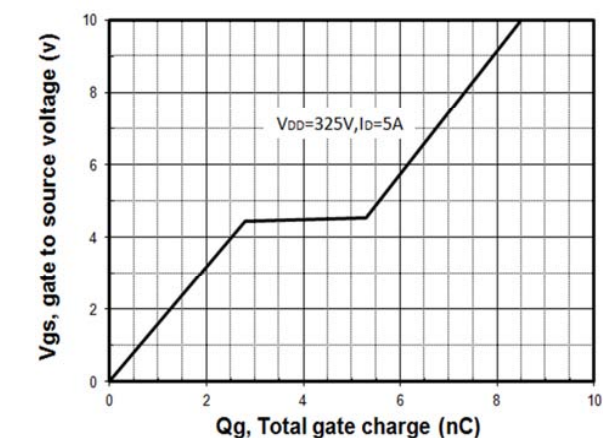


Figure 12. Typical Threshold Voltage vs Junction Temperature

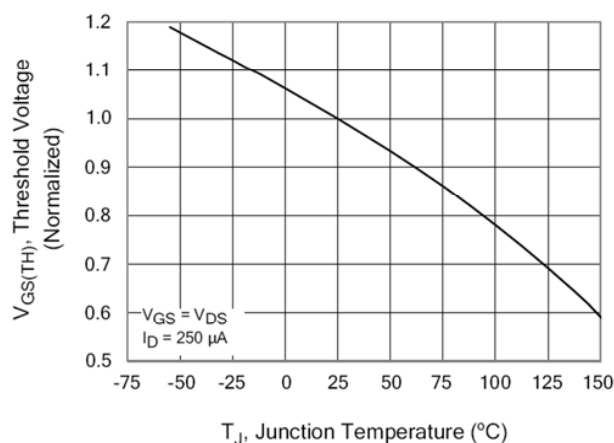
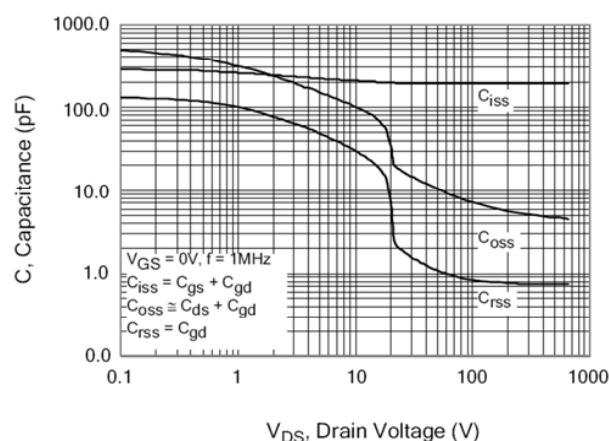


Figure 16. Typical Body Diode Transfer Characteristics



Test Circuits and Waveforms

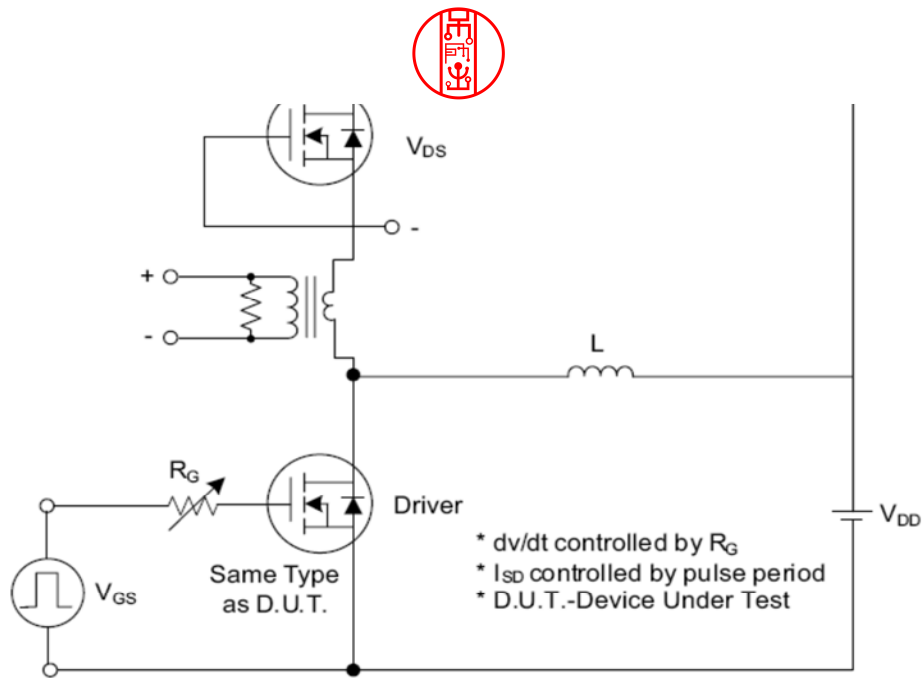


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

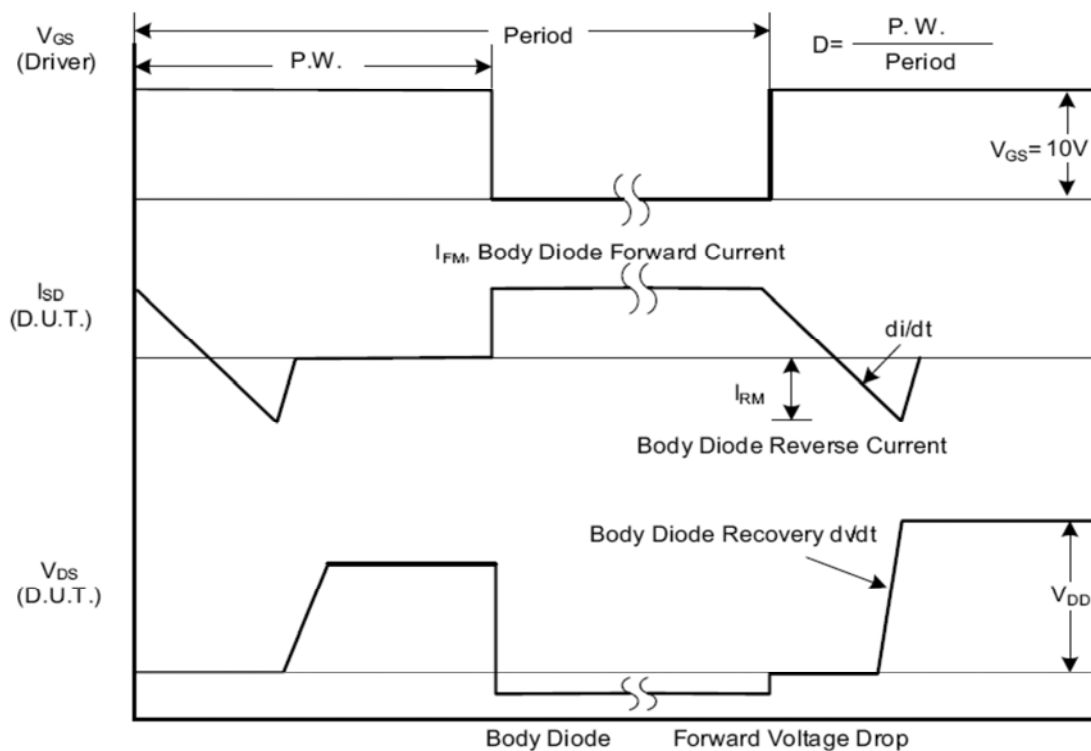


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms

Test Circuits and Waveforms (Cont.)

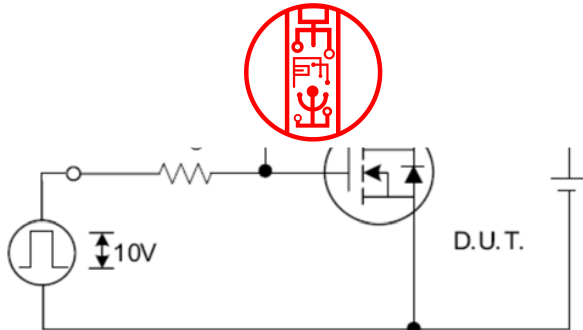


Fig. 2.1 Switching Test Circuit

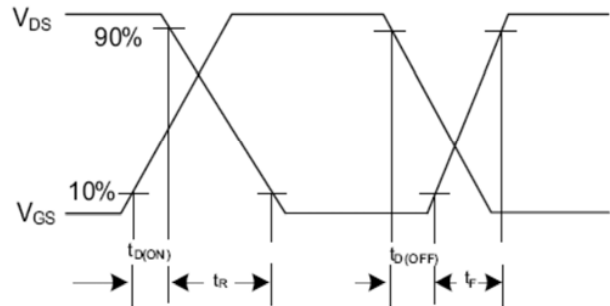


Fig. 2.2 Switching Waveforms

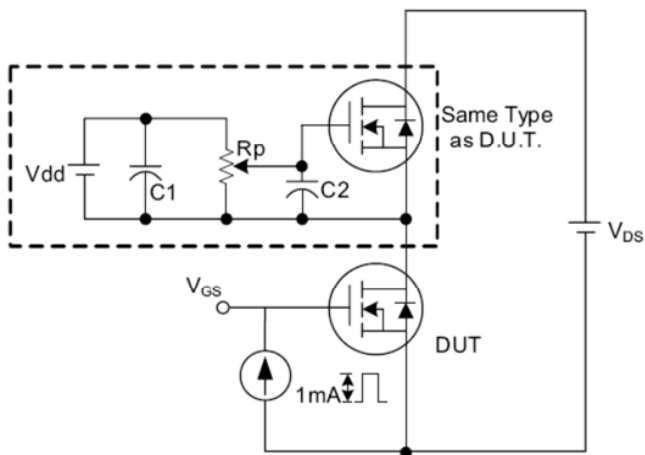


Fig. 3.1 Gate Charge Test Circuit

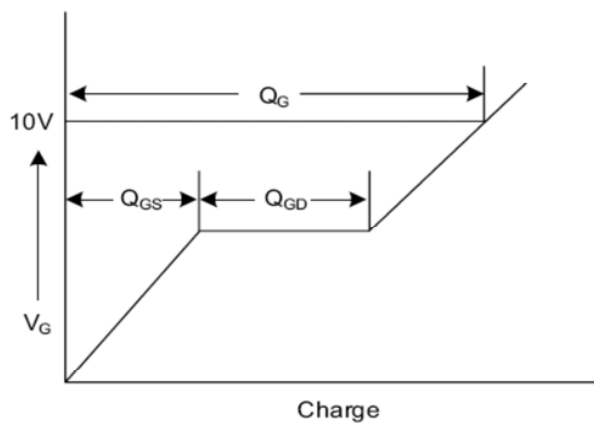


Fig. 3.2 Gate Charge Waveform

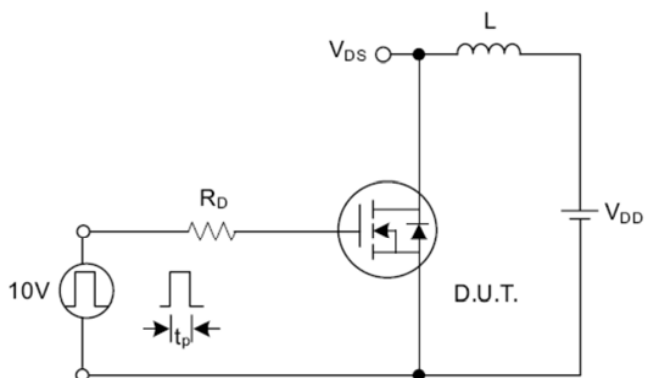


Fig. 4.1 Unclamped Inductive Switching Test Circuit

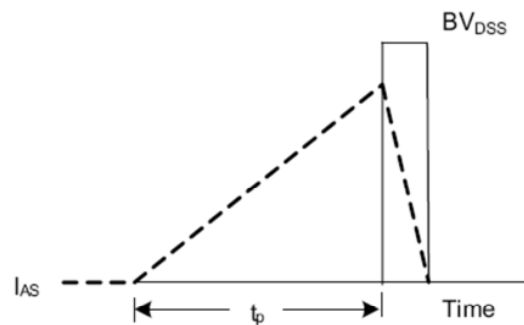


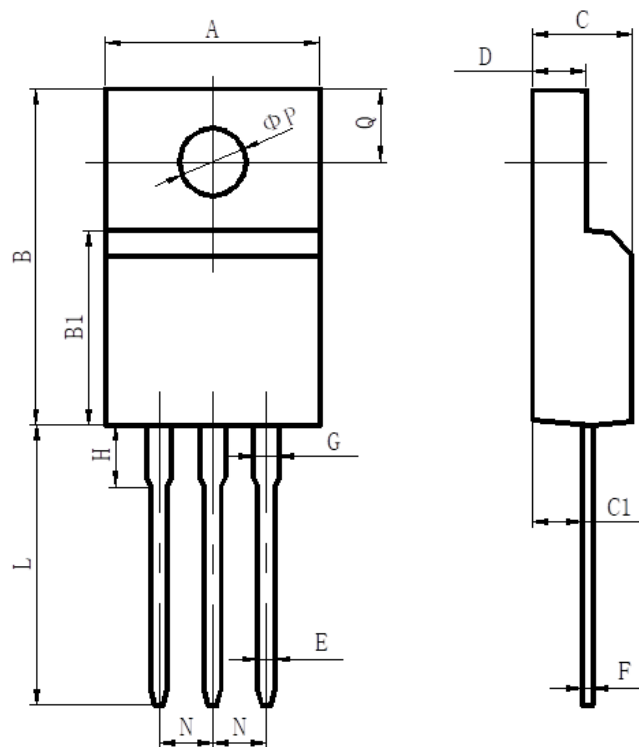
Fig. 4.2 Unclamped Inductive Switching Waveforms



SK03N50-TF

PACKAGE INFORMATION

TO-220F



	Unit (mm)	
	MIN	MAX
A	9.70	10.30
B	15.50	16.10
B1	8.99	9.39
C	4.40	4.80
C1	2.15	2.55
D	2.50	2.90
E	0.70	0.90
F	0.40	0.60
G	1.12	1.42
H	3.40	3.80
L	12.6	13.6
N	2.34	2.74
Q	3.15	3.55
Φ P	3.00	3.30